NTMS4706N

Power MOSFET
30 V, 10.3 A, Single N−Channel, SO−8

Features
- Low $R_{DS(on)}$
- Low Gate Charge
- Standard SO−8 Single Package
- Pb−Free Package is Available

Applications
- Notebooks, Graphics Cards
- Synchronous Rectification
- High Side Switch
- DC−DC Converters

ON Semiconductor®

http://onsemi.com

$V_{(BR)DSS}$	$R_{DS(ON)}$ TYP	I_D MAX (Note 1)
30 V	9.0 mΩ @ 10 V	10.3 A
	11.4 mΩ @ 4.5 V	

N−Channel

MARKING DIAGRAM/ PIN ASSIGNMENT

**SO−8
CASE 751
STYLE 12**

Pin		Pin
Source	1	Drain 8
Source		Drain
Source		Drain
Gate		Drain

4706N
ALYW■

Top View

4706N = Device Code
A = Assembly Location
L = WaferLot
Y = Year
WW = Work Week
■ = Pb−Free Package

(Note: Microdot may be in either location)

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain−to−Source Voltage			V_{DSS}	30	V
Gate−to−Source Voltage			V_{GS}	±20	V
Continuous Drain Current (Note 1)	Steady State	T_A = 25°C	I_D	8.6	A
		T_A = 85°C		6.2	
	t ≤ 10 s	T_A = 25°C		10.3	
Power Dissipation (Note 1)	Steady State	T_A = 25°C	P_D	1.5	W
	t ≤ 10 s			2.2	
Continuous Drain Current (Note 2)	Steady State	T_A = 25°C	I_D	6.4	A
		T_A = 85°C		4.6	
Power Dissipation (Note 2)		T_A = 25°C	P_D	0.83	W
Pulsed Drain Current	t_p = 10 μs		I_{DM}	31	A
Operating Junction and Storage Temperature			T_J, T_{stg}	−55 to 150	°C
Source Current (Body Diode)			I_S	2.1	A
Single Pulse Drain−to−Source Avalanche Energy (V_{DD} = 25 V, V_{GS} = 10 V, I_L Peak = 7.5 A, L = 10 mH, R_G = 25 Ω)			E_{AS}	150	mJ
Lead Temperature for Soldering Purposes (1/8″ from case for 10 s)			T_L	260	°C

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction−to−Ambient − Steady State (Note 1)	$R_{θJA}$	83.5	°C/W
Junction−to−Ambient − t ≤ 10 s (Note 1)	$R_{θJA}$	58	
Junction−to−Ambient − Steady State (Note 2)	$R_{θJA}$	150	

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.
1. Surfacemounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).
2. Surfacemounted on FR4 board using the minimum recommended pad size.

*For additional information on our Pb−Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.
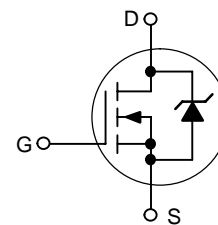
ORDERING INFORMATION

Device	Package	Shipping†
NTMS4706NR2	SO−8	2500/Tape & Reel
NTMS4706NR2G	SO−8 (Pb−Free)	2500/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

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ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Typ	Max	Unit
OFF CHARACTERISTICS							
Drain–to–Source Breakdown Voltage	$V_{(BR)DSS}$	V_{GS} = 0 V, I_D = 250 μA		30			V
Drain–to–Source Breakdown Voltage Temperature Coefficient	$V_{(BR)DSS}/T_J$				21		mV/°C
Zero Gate Voltage Drain Current	I_{DSS}	V_{GS} = 0 V, V_{DS} = 24 V	T_J = 25°C			1.0	μA
			T_J = 125°C			50	
Gate–to–Source Leakage Current	I_{GSS}	V_{DS} = 0 V, V_{GS} = ±20 V				±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	$V_{GS(TH)}$	V_{GS} = V_{DS}, I_D = 250 μA		1.0		2.5	V
Negative Threshold Temperature Coefficient	$V_{GS(TH)}/T_J$				−4.8		mV/°C
Drain–to–Source On Resistance	$R_{DS(on)}$	V_{GS} = 10 V, I_D = 10.3 A			9.0	12	mΩ
		V_{GS} = 4.5 V, I_D = 10 A			11.4	15	
Forward Transconductance	g_{FS}	V_{DS} = 15 V, I_D = 10 A			19		S
CHARGES, CAPACITANCES AND GATE RESISTANCE							
Input Capacitance	C_{iss}	V_{GS} = 0 V, f = 1.0 MHz, V_{DS} = 24 V			950		pF
Output Capacitance	C_{oss}				400		
Reverse Transfer Capacitance	C_{rss}				100		
Total Gate Charge	$Q_{G(TOT)}$	V_{GS} = 4.5 V, V_{DS} = 15 V, I_D = 10 A			10	15	nC
Threshold Gate Charge	$Q_{G(TH)}$				1.25		
Gate–to–Source Charge	Q_{GS}				2.4		
Gate–to–Drain Charge	Q_{GD}				4.5		
Gate Resistance	R_G				1.82		Ω
SWITCHING CHARACTERISTICS (Note 4)							
Turn–On Delay Time	$t_{d(on)}$	V_{GS} = 10 V, V_{DD} = 15 V, I_D = 1.0 A, R_G = 3.0 Ω			7.5	12	ns
Rise Time	t_r				4.0	8.0	
Turn–Off Delay Time	$t_{d(off)}$				24	40	
Fall Time	t_f				14	25	
DRAIN–SOURCE DIODE CHARACTERISTICS							
Forward Diode Voltage	V_{SD}	V_{GS} = 0 V, I_S = 2.1 A	T_J = 25°C		0.74	1.0	V
			T_J = 125°C		0.57		
Reverse Recovery Time	t_{RR}	V_{GS} = 0 V, d_{IS}/d_t = 100 A/μs, I_S = 2.1 A			34		ns
Charge Time	t_a				16		
Discharge Time	t_b				18		
Reverse Recovery Charge	Q_{RR}				29		nC

3. Pulse Test: pulse width = 300 μs, duty cycle ≤ 2%.
4. Switching characteristics are independent of operating junction temperatures.

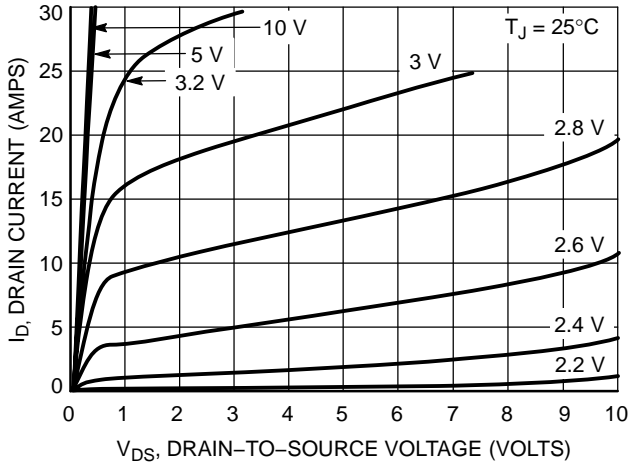# NTMS4706N

TYPICAL PERFORMANCE CURVES
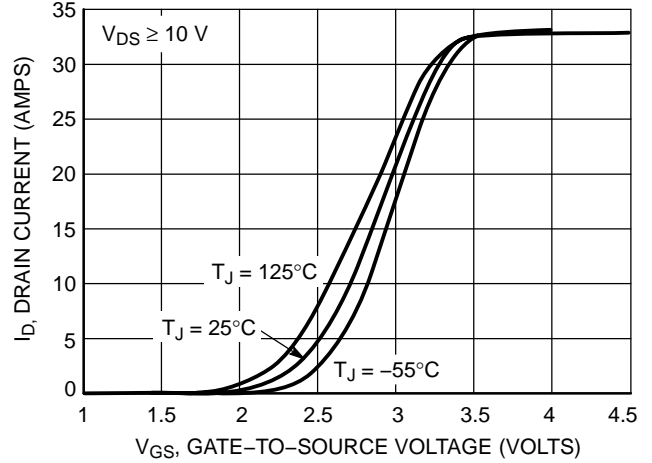

Figure 1. On−Region Characteristics

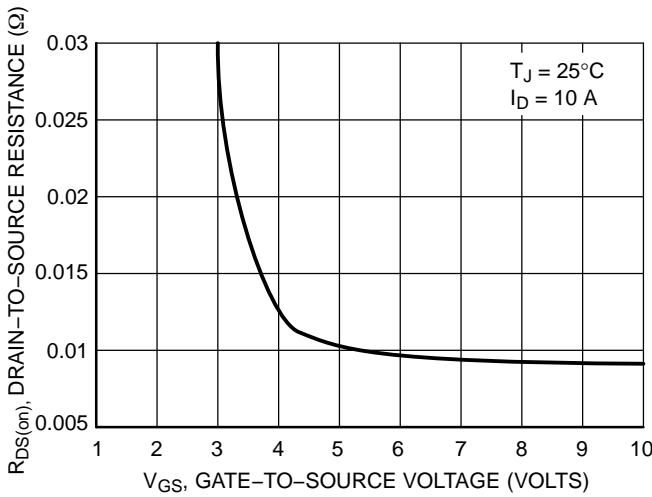Figure 2. Transfer Characteristics

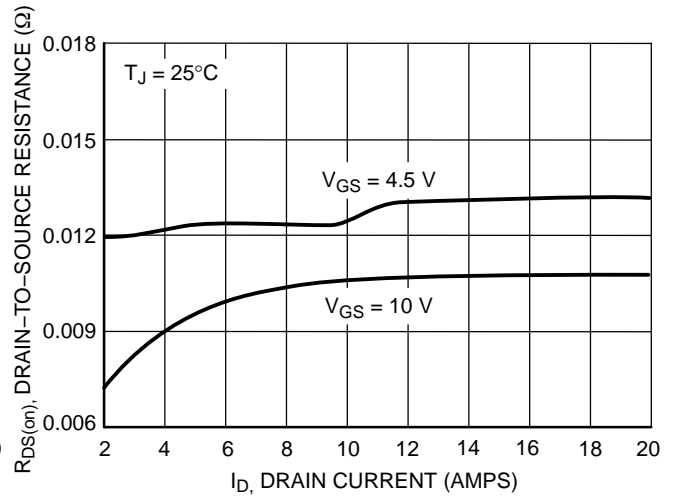Figure 3. On−Resistance vs. Gate−to−Source Voltage

Figure 4. On−Resistance vs. Drain Current and Gate Voltage
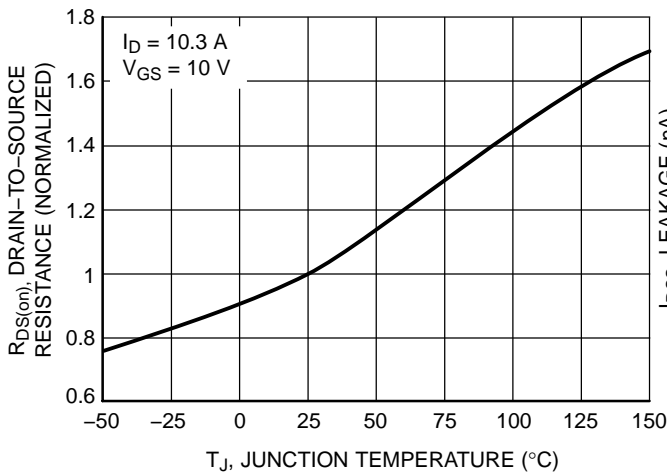

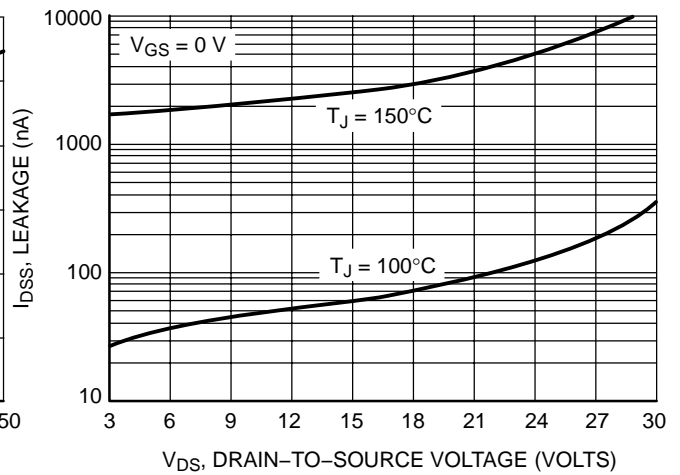Figure 5. On−Resistance Variation with Temperature

Figure 6. Drain−to−Source Leakage Current vs. Voltage
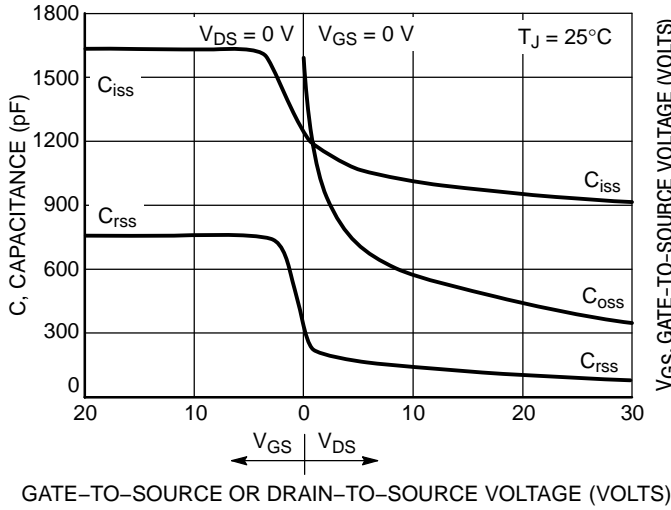
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TYPICAL PERFORMANCE CURVES

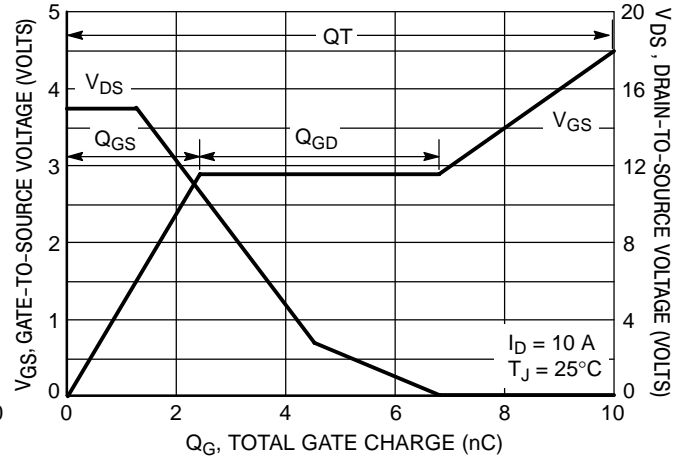**Figure 7. Capacitance Variation**
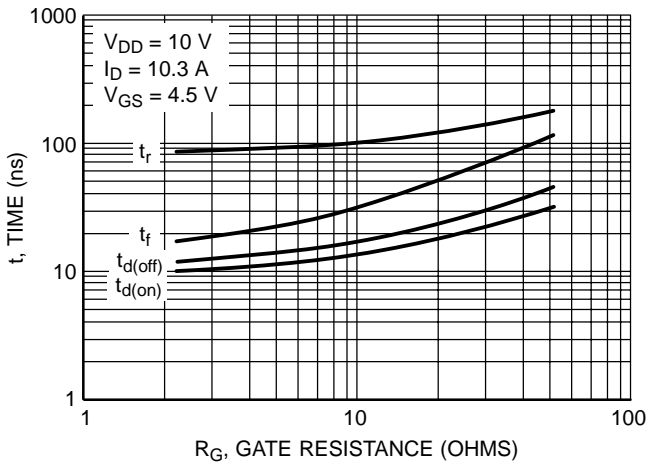

**Figure 8. Gate–To–Source and
Drain–To–Source Voltage vs. Total Charge**

**Figure 9. Resistive Switching Time
Variation vs. Gate Resistance**
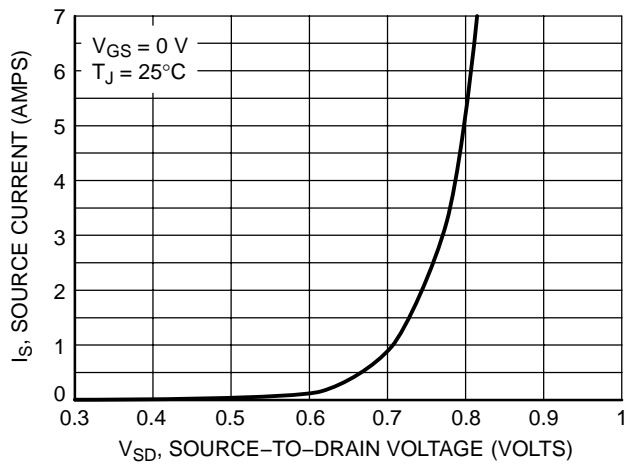
Figure 10. Diode Forward Voltage vs. Current

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PACKAGE DIMENSIONS

SOIC−8
CASE 751−07
ISSUE AG
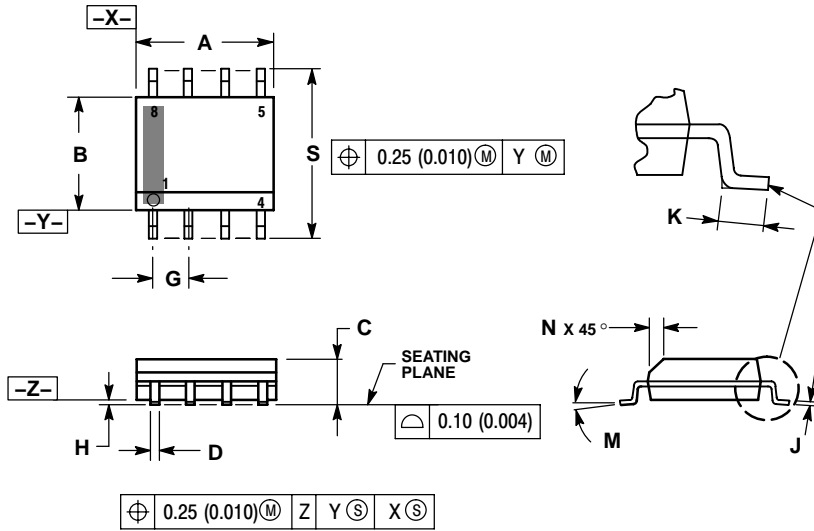
NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
4. MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.
5. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.
6. 751−01 THRU 751−06 ARE OBSOLETE. NEW STANDARD IS 751−07.

DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.80	5.00	0.189	0.197
B	3.80	4.00	0.150	0.157
C	1.35	1.75	0.053	0.069
D	0.33	0.51	0.013	0.020
G	1.27 BSC		0.050 BSC	
H	0.10	0.25	0.004	0.010
J	0.19	0.25	0.007	0.010
K	0.40	1.27	0.016	0.050
M	0 °	8 °	0 °	8 °
N	0.25	0.50	0.010	0.020
S	5.80	6.20	0.228	0.244

STYLE 12:
PIN 1. SOURCE
2. SOURCE
3. SOURCE
4. GATE
5. DRAIN
6. DRAIN
7. DRAIN
8. DRAIN

SOLDERING FOOTPRINT*
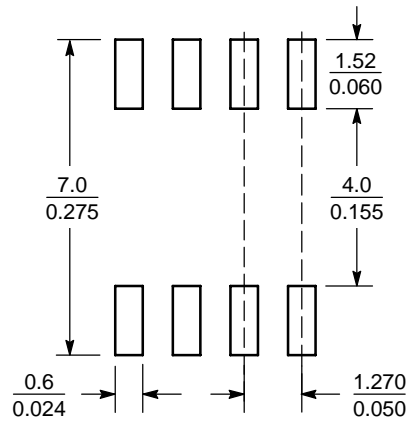
SCALE 6:1 $\left(\frac{mm}{inches}\right)$

*For additional information on our Pb−Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PUBLICATION ORDERING INFORMATION

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